Power MOSFET

25 V, 44 A, Single N-Channel, DPAK/IPAK

Features

- Trench Technology
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

Applications

- VCORE Applications
- DC-DC Converters
- High/Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Para	ameter		Symbol	Value	Unit
Drain-to-Source Vo	Itage	V_{DSS}	25	V	
Gate-to-Source Vol	tage		V_{GS}	±20	V
Continuous Drain		T _A = 25°C	Ι _D	10.5	Α
Current R _{0JA} (Note 1)		T _A = 85°C		8.1	
Power Dissipation R ₀ JA (Note 1)		T _A = 25°C	P _D	1.92	W
Continuous Drain	1	T _A = 25°C	Ι _D	8.5	Α
Current R _{θJA} (Note 2)	Steady State	T _A = 85°C		6.6	
Power Dissipation R ₀ JA (Note 2)	Siale	T _A = 25°C	P _D	1.27	W
Continuous Drain	1	T _C = 25°C	Ι _D	44	Α
Current R _{θJC} (Note 1)		T _C = 85°C		34	
Power Dissipation R _{θJC} (Note 1)		T _C = 25°C	P _D	33.3	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	87	Α
Current Limited by P	ackage	T _A = 25°C	I _{DmaxPkg}	35	Α
Operating Junction a Temperature	Operating Junction and Storage Temperature				°C
Source Current (Bod	ly Diode)	I _S	28	Α	
Drain to Source dV/c	dt	dV/dt	6	V/ns	
Single Pulse Drain-to-Source Avalanche Energy (T_J = 25°C, V_{DD} = 50 V, V_{GS} = 10 V, I_L = 10 A_{pk} , L = 1.0 mH, R_G = 25 Ω)			EAS	50	mJ
Lead Temperature for (1/8" from case for 1		TL	260	°C	

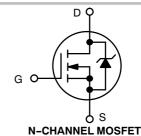
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
25 V	10.9 mΩ @ 10 V	44 A
20 V	17.2 mΩ @ 4.5 V	44 A







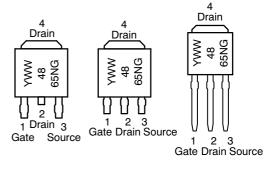


CASE 369AA **DPAK** (Bent Lead) STYLE 2

CASE 369AC 3 IPAK (Straight Lead) (Straight Lead

CASE 369D IPAK DPAK)

MARKING DIAGRAMS & PIN ASSIGNMENTS



= Year WW = Work Week 4865N = Device Code = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	4.5	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	78	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	118.5	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS			_				
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		25			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				23		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, T _J = 25°C				1.0	
		V _{DS} = 20 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.45		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	R _{DS(on)} V _{GS} = 10 V I _D = 30 A			8.9	10.9	0
		V _{GS} = 4.5 V	I _D = 30 A		13.9	17.2	'.2 mΩ
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 15 A			39		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 12 V			827		pF
Output Capacitance	C _{OSS}				223		
Reverse Transfer Capacitance	C _{RSS}				111		1
Total Gate Charge	Q _{G(TOT)}				7.2	10.8	
Threshold Gate Charge	Q _{G(TH)}	\/ 4E\/\/	15 \/ \ \ 20 A		0.8		nC
Gate-to-Source Charge	Q _{GS}	V_{GS} = 4.5 V, V_{DS} =	15 V, I _D = 30 A		3.0		
Gate-to-Drain Charge	Q_{GD}				3.3		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} =	15 V, I _D = 30 A		14.6		nC
SWITCHING CHARACTERISTICS (Note	4)						
Turn-On Delay Time	t _{d(ON)}				10.3		
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			24.6		ns
Turn-Off Delay Time	t _{d(OFF)}				11.4		
Fall Time	t _f				3.5		1
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 11.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			5.4		
Rise Time	t _r				19		1
Turn-Off Delay Time	t _{d(OFF)}				17.4		ns
Fall Time	t _f				2.3		1

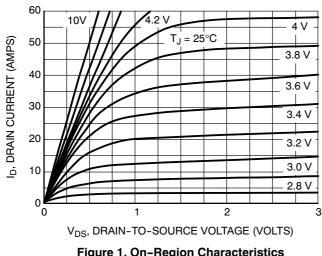
- 3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%. 4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACT	ERISTICS				-		
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		1.0	1.2	
		$V_{GS} = 0 V,$ $I_{S} = 30 A$	T _J = 125°C		0.89		\ \
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/μs, I _S = 30 A			10.6		ns
Charge Time	t _a				7.0		
Discharge Time	t _b				3.6		
Reverse Recovery Charge	Q _{RR}				1.7		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S	T _A = 25°C			2.49		nH
Drain Inductance, DPAK	L _D				0.0164		
Drain Inductance, IPAK	L _D				1.88		
Gate Inductance	L _G				3.46		
Gate Resistance	R_{G}				0.75		Ω

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

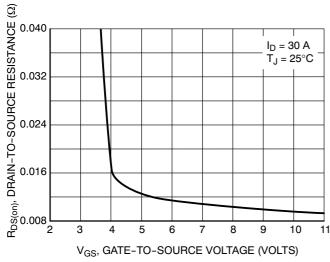
TYPICAL PERFORMANCE CURVES



60 $V_{DS} \ge 10 \text{ V}$ ID, DRAIN CURRENT (AMPS) 50 40 30 20 T_J = 125°C 10 $T_J = 25^{\circ}C$ T_J = -55°C 0 L 3 2 5 V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



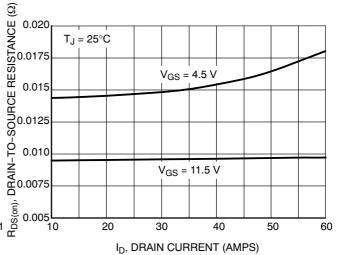
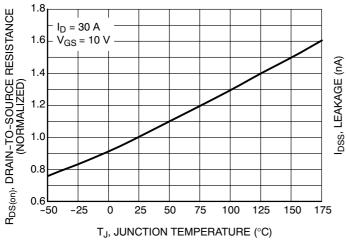


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**



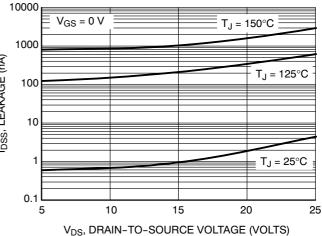


Figure 5. On-Resistance Variation with **Temperature**

Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

TYPICAL PERFORMANCE CURVES

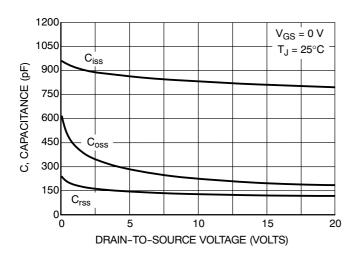


Figure 7. Capacitance Variation

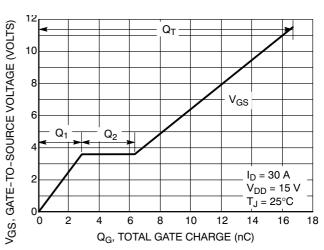


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

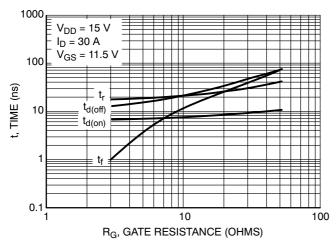


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

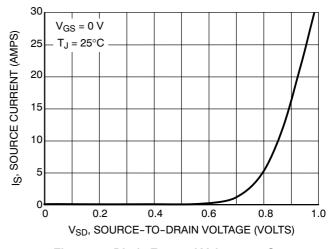


Figure 10. Diode Forward Voltage vs. Current

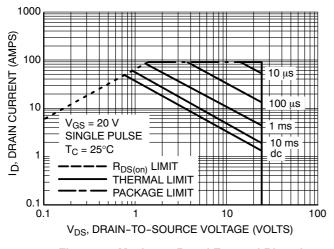


Figure 11. Maximum Rated Forward Biased Safe Operating Area

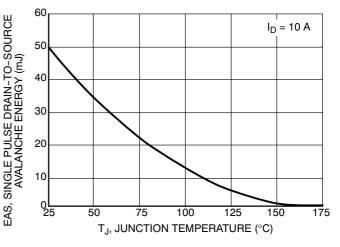


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

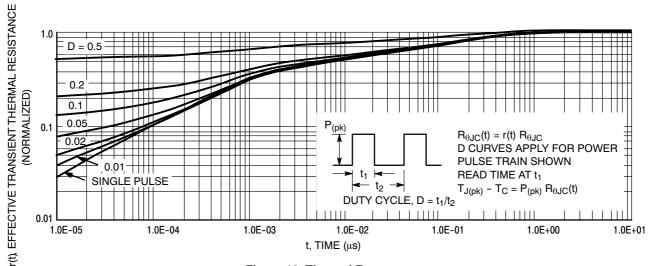


Figure 13. Thermal Response

ORDERING INFORMATION

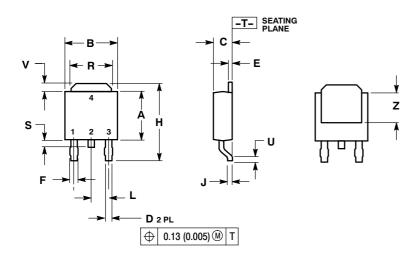
Device	Package	Shipping [†]
NTD4865NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD4865N-1G	IPAK (Pb-Free)	75 Units / Rail
NTD4865N-35G	IPAK Trimmed Lead (3.5 \pm 0.15 mm) (Pb-Free)	75 Units / Rail

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE)

CASE 369AA-01 **ISSUE A**



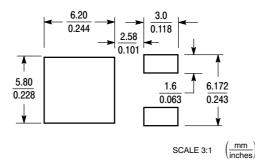
- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.025	0.035	0.63	0.89
E	0.018	0.024	0.46	0.61
F	0.030	0.045	0.77	1.14
Н	0.386	0.410	9.80	10.40
J	0.018	0.023	0.46	0.58
L	0.090 BSC		2.29	BSC
R	0.180	0.215	4.57	5.45
S	0.024	0.040	0.60	1.01
U	0.020		0.51	
V	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2:

- PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

SOLDERING FOOTPRINT*

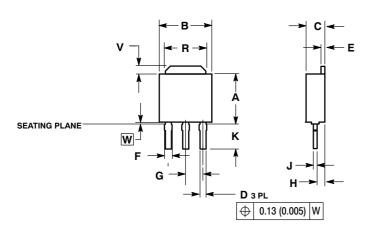


^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

3 IPAK, STRAIGHT LEAD

CASE 369AC-01 ISSUE O



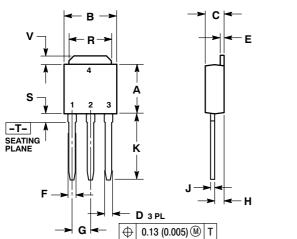
NOTES:

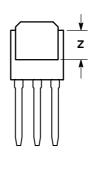
- 1.. DIMENSIONING AND TOLERANCING
- PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- SEATING PLANE IS ON TOP OF DAMBAR POSITION.
- DIMENSION A DOES NOT INCLUDE DAMBAR POSITION OR MOLD GATE.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
C	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.043	0.94	1.09
G	0.090	0.090 BSC		BSC
Н	0.034	0.040	0.87	1.01
7	0.018	0.023	0.46	0.58
K	0.134	0.142	3.40	3.60
R	0.180	0.215	4.57	5.46
٧	0.035	0.050	0.89	1.27
w	0.000	0.010	0.000	0.25

IPAK (STRAIGHT LEAD DPAK)

CASE 369D-01 **ISSUE B**





- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2:

PIN 1. GATE

- DRAIN
 SOURCE

DRAIN

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